

Hidden Errors in Simulations and the Quality of Pseudorandom Numbers

In a recent letter Ferrenberg *et al.* (FLW) [1] present intriguing results arising from combinations of some random number generators and Monte Carlo acceleration algorithms. In particular, they observe systematic errors when the Wolff algorithm [2] is used at T_c in the $2 - d$ Ising model. As an explanation of this, they propose that subtle correlations arise in the random number sequences, in the sense that the higher order bits of the random numbers are correlated.

We have recently carried out extensive statistical, bit level, and visual tests for several commonly used pseudorandom number generators in physics applications [3]. Two of these were used in Ref. 1, namely R250 [4] and CONG [5]. Using the Wolff algorithm FLW discovered problems with R250, but not with CONG. Thus, our test results bear direct relevance to the existence of possible problems, and differences between these two algorithms.

To directly probe the correlations between each bit of consecutive pseudorandom numbers, we have performed two quantitative tests. The first one is an extended version of the m -tuple test [6]. The second test was based on the range of binary random matrices [7]. In Table 1 we present a summary of the results for each of the 31 significant bits from random numbers generated by R250 and CONG. Our results indicate no bit level correlations in CONG. The same is true for R250, *provided* it is properly initialized. This is demonstrated in Table 2, where R250 was initialized by a lagged Fibonacci generator RAN3 [8], which contains several correlated bits, including five of the most significant ones. As seen in the results, correlations from RAN3 transform into R250.

Our results thus indicate that the problems observed in Ref. 1 have no simple explanation in terms of bit level correlations. We note that both R250 and CONG were also subjected to an array of statistical tests [3,5], in which neither of them

showed any particular weaknesses. However, our $2 - d$ visual tests did reveal a periodic spatial fine structure in CONG, a result not unexpected with this type of algorithm [3]. Yet, no problems with CONG were reported by FLW. Since their results presently have no clear explanation, we wholeheartedly agree with them on the importance of careful physical tests [3] before a particular "good quality" generator is chosen for simulations.

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Table Captions:

Random number generator	Failing bits in the m -tuple test	Failing bits in the random matrix test
R250	none	none
CONG	none	none

Table 1. The results of an extended m -tuple test with parameters $m = t = 3$, and a test using 2×2 random matrices. In these tests R250 was initialized by CONG.

Random number generator	Failing bits in the m -tuple test	Failing bits in the random matrix test
R250	1 - 2, 27 - 31	1, 27 - 31
RAN3	1 - 5, 25 - 30	1 - 5, 26 - 30

Table 2. The results of bit level tests for R250 initialized by RAN3.